SURFACE ROUGHNESS/CONTOUR MEASURING SYSTEM FORMTRACER SV-C3200/4500 SERIES

Dual-purpose measurement and powerful analysis of surface roughness and contour combined with high accuracy, high drive speed and simplified CNC measurement



Bulletin No. 2195

FORM MEASUREMENT

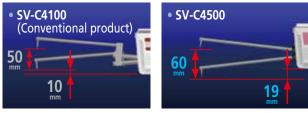
Hybrid measuring instrument for surface roughness and contour measurement

Contour Measuring Functions

Detector with new arm design

Mitutoyo's newly designed detector arm lowers workpiece interference while expanding the measurement range in the Z1 axis (detector).

• When using the SPH-71 one-sided cut stylus



Detector measurement range expanded by 10 mm

One-touch arm attachment (Patent pending in Japan) The arm mount uses a magnetic joint for quick and easy arm replacement. The mount also includes a safety mechanism.

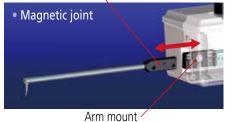


Screw fixing





Removable arm

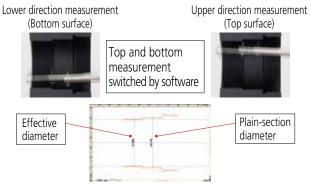


New function specified for 4500 Series

Continuous top-bottom measurement function

Upper and lower surfaces can be measured continuously by using Mitutoyo's double-sided conical stylus.

This continuous measurement data can be used to facilitate analysis of features that were difficult to measure before, such as the effective diameter of an internal screw-thread.



Continuous top-bottom measurement allows hassle-free one-step calibration

(Patent pending in Japan)

The one-step calibration kit supplied with the SV-C4500 Series has been upgraded to enable easy calibration of the double-ended conical stylus featuring a contact on both the top and the bottom. Precise work such as calibrating the Z1-axis gain, symmetry, and stylus radius can now be carried out in a single operation.

Calibration kit for SV-C4500 Series



Variable measuring force function

The measuring force can be varied in 5 steps by using the software provided (**FORMTRACEPAK**), eliminating the need to adjust

the measuring force by switching weights or through positional adjustment.

The SV-C4500 Series can also maintain the specified measuring force even when tilted.





Surface Roughness Measuring Functions

Common specifications

Supporting International Standards

Compliant with JIS '82/'94/'01, ISO, ANSI, DIN, VDA, and other international surface roughness standards.

We offer a product lineup of surface roughness detectors with different measuring forces

Standard detectors can be selected (as listed below) to conform to the international standard required. 0.75mN (tip angle 60°; tip radius 2µm) 4mN (tip angle 90°; tip radius 5µm)

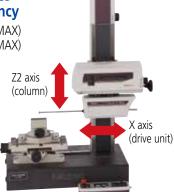
Reduction of measuring time and operator's fatigue

In addition to high speed movement of main unit, reduction of setting time and operator's fatigue can be achieved by using Auto-leveling Table (option), which allows automatic leveling for a measuring face.

Fast traverse improves measurement efficiency

X axis (drive unit) : 80mm/s (MAX) Z2 axis (column) : 30mm/s (MAX)

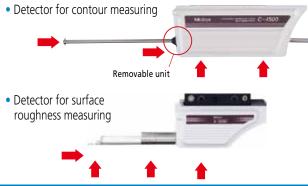
The total measurement time can be shortened by speeding up the traverse movements.



Auto stop feature assures safety even during high-speed movement

The detector includes a safety mechanism (auto stop upon collision) to assure measurement safety even during highspeed movement. If the arm is removed or shifts during measurement, the safety mechanism is triggered and stops the machine.

Direction of collision that may cause the safety device to be triggered



Remote-control unit enables safe, easy & fast measurement

The remote-control unit lets you move quickly from positioning to measurement. The unit also features an emergency stop switch and speed control knob for added safety while the machine is moving at high speeds.

Emergency stop switch — Drive speed control knob –



New Remote Control Box

Incorporation of an ABS scale in the Z2 axis eliminates

the need for wearisome origin point re-setting conventionally required for every step of repeated measurements over stepped or multiple sections.

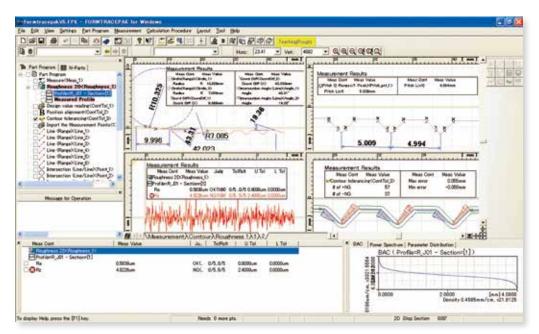


All detector and drive unit cables are housed inside the main unit to eliminate any risk of abrasion and guarantee trouble

free, high-speed operation.



Contour Analysis Software: FORMTRACEPAK

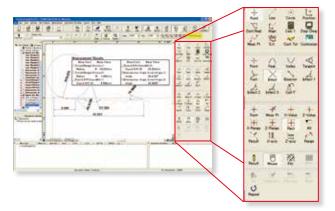


Contour Measuring

Contour analysis function

Upper and lower surfaces can be measured continuously by using Mitutoyo's double-sided conical stylus.

This continuous measurement data can be used to facilitate analysis of features that were difficult to measure before, such as the effective diameter of an internal screw-thread.



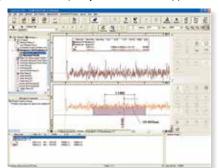
- Contour-tolerancing function as a standard feature
- Design value generation function
- Data combination function
- Simple pitch calculation function

Surface Roughness Measuring

• Surface Roughness analysis function

FORMTRACEPAK can perform surface roughness analyses that conform to various standards such as ISO, JIS ANSI, and VDA. For comparing the measurement values with the tolerance limits, you can use the 16% rule or the maximum value rule. Furthermore, since FORMTRACEPAK comes with parameter calculation functions as well as a rich set of graphic analysis functions, it can be widely utilized for everything from routine quality control to R&D applica-

tions. It also includes many other functions, such as the function for eliminating (compensating) shapes, such as slopes and Rsurface, and a data deletion function.



- Microscopic contour analysis function
- Simple input using drawing symbols
- Multiple-point measurement function
- Analysis function using multiple-point measurement
- Reference length dialog box
- Analysis condition modification with a preview function
- R-surface automatic measurement function

Note: Please refer to the FORMTRACEPAK catalog (E4386) for more details.



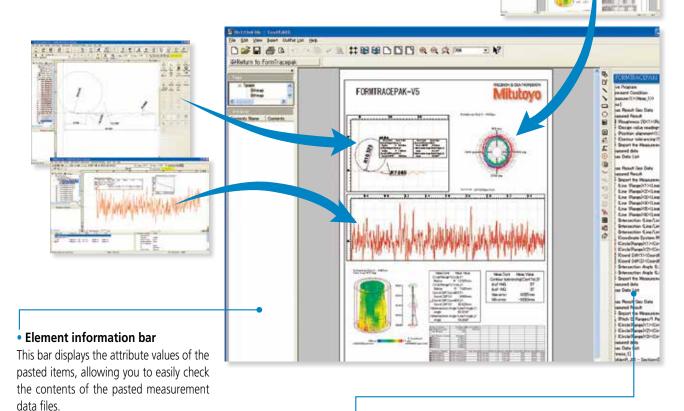


FORM

Integrated layout

You can use simple operations to lay out graphics obtained from measurements as well as measurement results for surface roughness, contour, and roundness on a single page. Furthermore, since the program now allows you to specify a saved file and paste it, you can easily paste results from multiple files.

Note: the optional ROUNDPAK roundness/cylindricity analysis program is required. (Ver. 7 or higher)



System layout printing

Report creation function

By simply selecting the items to be output, you can automatically lay out the page to be printed.

Use this feature when you wish to simplify the printing task.



Element insertion bar

Using the mouse to drag and drop the analysis content displayed in the element insertion bar, you can paste it onto the layout. From the contour analysis result, you can also select the analysis result for a circle or line alone and paste it in position.

Saving the result as a web page

Since you can save the result in html or mhtml format, which can be displayed using Internet Explorer or Microsoft Word, you can check the result even on a PC in which no layout-editing program is installed.

You can freely assemble measurement results/conditions/graphics as well as comments/circles/lines/arrows, and print them out in a measurement result report. Furthermore, since you can paste bitmap files, you can also add a workpiece image or company logo to the layout. You can also save the created layout and use it again later for similar measurements.

Optional Accessories for Automatic Measurement

Y-axis table: 178-097 / 178-096

A Y-axis table for positioning and capable of 3D surface roughness measurement when used with FORMTRACEPAK-Pro or MCubeMap.



	178-097	178-096
Travel range	200mm	100mm
Resolution	0.05µm	0.05µm
Positioning accuracy	±3μm	-
Straightness accuracy	-	0.3µm/100mm
Drive speed	Max. 80mm/s	0-20mm/s
Maximum load	50kg	15kg
Mass	28kg	31kg

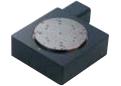


*Not supporting Y-axis measurements

Rotary Table (1-axis table: 12AAD975*

For efficient measurement in the axial/transverse directions. When measuring a cylindrical workpiece, automatic alignment can be performed in combination with the Y-axis table.

*01-axis mounting plate (12AAE630) is required when directly installing on the base of the SV-C3200/4500.



Displacement	360°
Resolution	0.004°
Maximum load	12kg
Rotational speed	Max. 10°/s
Mass	7kg



Rotary Table θ 2-axis unit: 178-078*

You can measure multiple points on a cylindrical workiece and automate front/rear-side measurement. *θ2 -axis mounting plate (12AAE718) is required when directly installing on the base of the SV-C3200/4500.



Displacement	360°
Resolution	0.0072°
Maximum load (loading moment)	4kg (343 N•cm or less)
Rotational speed	Max. 18°/s
Mass	5kg

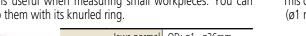


Centering chuck (ring operated): 211-032

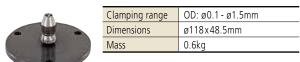
This chuck is useful when measuring small workpieces. You can easily clamp them with its knurled ring.

This chuck is suitable for clamping extra-small diameter workpieces

Micro-chuck: 211-031



(ø1 mm or less), which cannot be retained with the centering chuck.





Clamping range	Jaws normal	OD: ø1 - ø36mm
	Jaws normal	ID: ø16 - ø69mm
	Jaws reversed	OD: ø25 - ø79mm
Dimensions		ø118x41mm
Mass		1.2kg

Auto-leveling table: 178-087 / 178-077

This is a stage that performs fully automatic leveling as measurement starts, freeing the user from this troublesome operation. Fully automatic leveling can be done guickly by anyone. In addition, the operation is easy and reliable.



	178-087	178-077
Inclination adjustment angle	±2°	±2°
Maximum load	7kg	-
Maximum load (on Y-axis table)	-	10kg
Maximum load (on Y-axis table + Theta-1-axis table)	-	6kg
Table dimensions	130x100mm	139x139mm
Mass	3.5kg	4.5kg
Mass	28kg	31kg



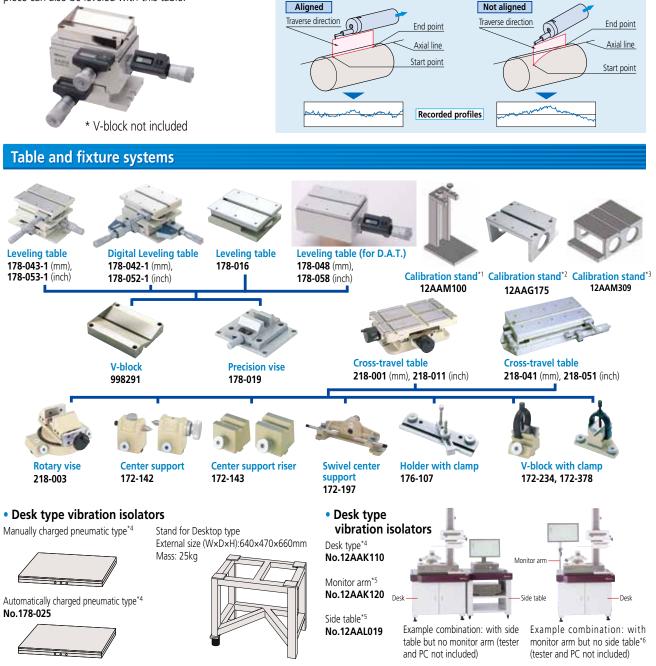
*Used with 178-096 for 3D surface roughness measurements



Options

3-axis Adjustment Table: 178-047

This table helps make the alignment adjustments required when measuring cylindrical surfaces. The corrections for the pitch angle and the swivel angle are determined from a preliminary measurement and the Digimatic micrometers are adjusted accordingly. A flat-surfaced work-piece can also be leveled with this table.



*1 Required for calibrating upward measurement of SV-C3200 series.

*2 Required for calibrating in bulk by mounting straight arm/small-hole stylus arm without using cross-travel table and Y-axis table.

- *3 Required for calibrating in bulk by mounting straight arm/eccentric arm/small-hole stylus arm without using cross-travel table and Y-axis table.
- *4 For models with a product code that ends in S4, S8, H4, or H8. Please contact us directly if you require units for models with a product code that ends in W4 or W8 (large base models).

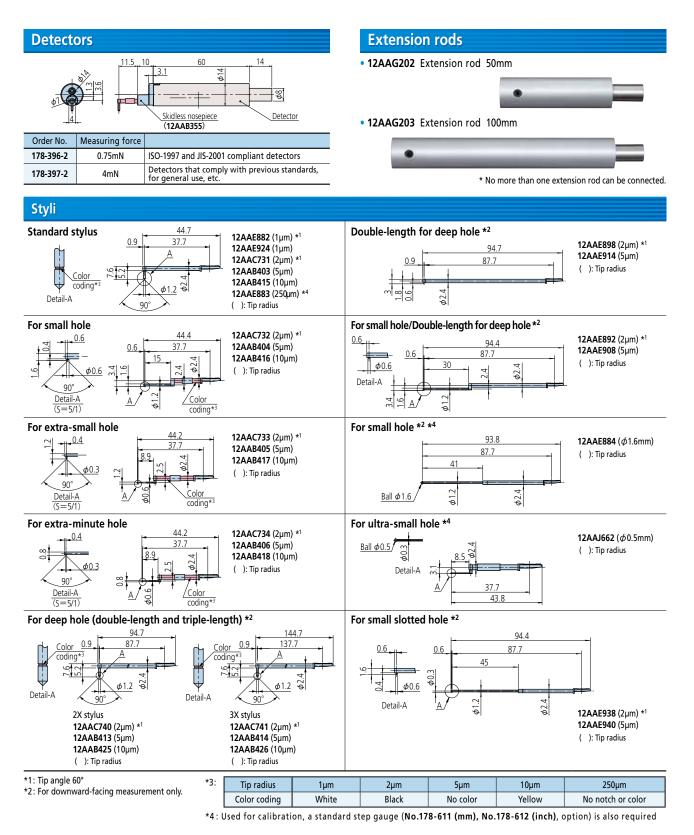
*5 Used together with vibration isolator (No.12AAK110).

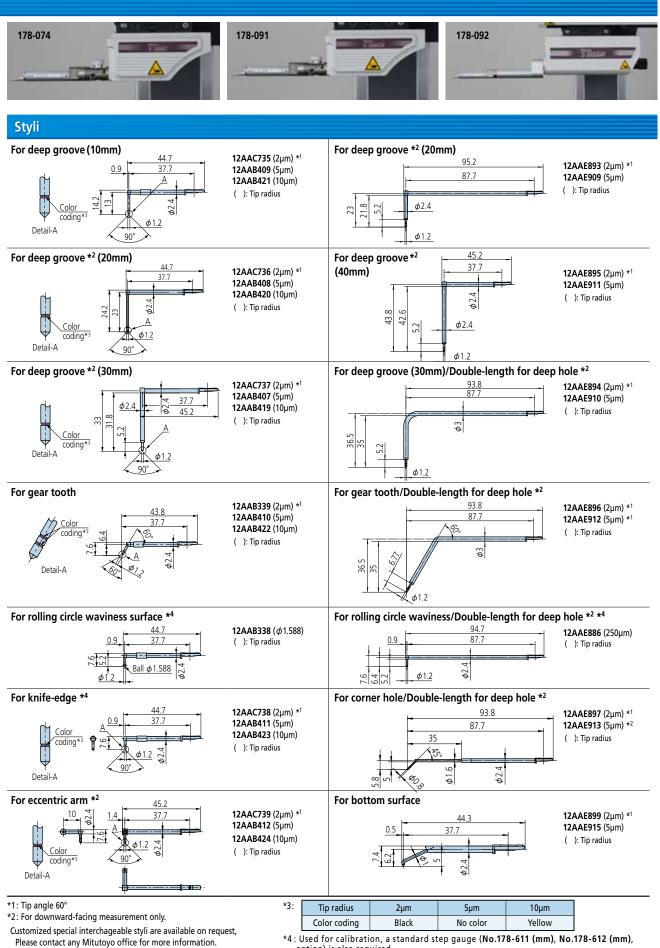
*6 User to provide a printer rack.

Detectors / Styli (For Surface Roughness Measuring)

Optional Detector Holders

Code No.	Detector Holder	Description	Applicable Series
178-074	S-3000C	Crank type Detector Holder	SV-C3200/4500
178-091	S-3000CR	Crank Rotational type Detector Holder	SV-C3200/4500
178-092	S-3000MR	Manual Rotational type Detector Holder	SV-C3200/4500





option) is also required

Arms / Styli (For Contour Measuring)

Arms

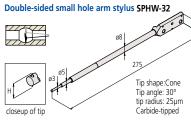
							_	
Description	Arm No.	Parts No.		e stylus No.	• Str	aight arm AB-31	 Eccentric arm AB-37 	• Small-hole arm AB-33
traight arm	AB-31*1	12AAM101	SPH-5*, 6*, SPHW* ² -56			2000 20	No.	20
ccentric arm	AB-37	12AAQ762	SPH-5*, 6*, SPHW* ² -56			08 57.5	28	57.5 08 57.5
mall-hole arm	AB-33	12AAM103	SPH-41, 42,					\checkmark \land \checkmark
Standard access	001		1. , ,			218*1	218*3	218
Stylus for SV-C4 One-sided cut s	500 series	l (standard ac	ccessory) moun	ting				
Styli								
Stylus name		lus No.	Parts No.	Application arm No		Double-sided conical stylus	Cone stylus	Small hole stylus SPH-41
	SPHW		AM095*2	AB-31, AB-37	20	ø3 . rzzzi	ø <u>3</u>	
Double-sided conical st	SPRIV		AM096	AB-31, AB-37	32			ø4.8
	SPHW		AM097	AB-31, AB-37	48			
	SPH-5		882	AB-31, AB-37	6	M M		Ø1.6 55
	SPH-6			AB-31, AB-37	12		∇	1 55
One-sided cut stylus	SPH-7		884 * ^{2*3}	AB-31, AB-37	20	JILI''	v	Tip shape: One-sideo
	SPH-8		885	AB-31, AB-37	30	Tip angle: 30°	Tip angle: 30° (SPH-79: 50°)	H Tip angle: 20°
	SPH-9			AB-31, AB-37	42	Tip radius: 25µm	Tip radius: 25µm	Tip radius: 25µm
	SPH-5			AB-31, AB-37	6	Carbide-tipped	Sapphire, Carbide-tipped	Carbide-tipped
	SPH-6			AB-31, AB-37	12	 Carbiac appea 	(SPH-79:Diamond tipped)	carbide apped
ntersecting cut stylus	SPH-7			AB-31, AB-37	20		(SITI-75.Diamona upped)	
	SPH-8			AB-31, AB-37	30			
	SPH-9			AB-31, AB-37	42	One-sided cut stylus	Cone stylus	Small hole stylus SPH-42
	SPH-5			AB-31, AB-37	6	a3	ø3	
Cone stylus	SPH-6			AB-31, AB-37	12			
Tip angle 30°	SPH-7			AB-31, AB-37	20			
Sapphire tipped	SPH-8			AB-31, AB-37	30			03
	SPH-9			AB-31, AB-37	42		H CEF	55
	SPH-5	i6 12A	AA566	AB-31, AB-37	6	Tip angle: 12°	Tip angle: 20°	
Cone stylus	SPH-6	i6 12A	AA567	AB-31, AB-37	12			Tip shape: One-sided
Tip angle 30°	SPH-7	'6 12A	AA568	AB-31, AB-37	20	Tip radius: 25µm	Tip radius: 25µm	H 1 Tip angle: 20°
Carbide-tipped	SPH-8	6 12A	AA569	AB-31, AB-37	30	Carbide-tipped	Carbide-tipped	Tip radius: 25µm
	SPH-9	6 12A	AA570	AB-31, AB-37	42			Carbide-tipped
	SPH-5		AE865	AB-31, AB-37	6			Carbide-tipped
Cone stylus	SPH-6		AE866	AB-31, AB-37	12			
Tip angle 20°	SPH-7		AE867	AB-31, AB-37	20	Intersecting cut stylus	Knife edge stylus	Small hole stylus SPH-43
Carbide-tipped	SPH-8		AE868	AB-31, AB-37	30	ø3	ø3	
	SPH-9		AE869	AB-31, AB-37	42			
Cone stylus Tip angle 50° Diamond tipped	SPH-7			AB-31, AB-37	20	H K	H h	04
namona uppea	SPH-5	4 354	897	AB-31, AB-37	6	WI	M i –	55
	SPH-6		898	AB-31, AB-37	12	Tip angle: 20°	Tip angle: 20°	
Knife edge stylus	SPH-0			AB-31, AB-37 AB-31, AB-37	20	Tip radius: 25µm	Edge width: 3mm	Tip shape:One-sided
time euge stylus	SPH-7 SPH-8			AB-31, AB-37 AB-31, AB-37	30	Carbide-tipped	Tip radius: 25µm	H Tip angle: 20°
	SPH-8 SPH-9				42	Camine-rihhed		12.5 Tip radius: 25µm
				AB-31, AB-37			Carbide-tipped	Carbide-tipped
	SPH-5			AB-31, AB-37	6			cubide apped
All and an	SPH-6			AB-31, AB-37	12		Ball stylus	
all stylus	SPH-7			AB-31, AB-37	20		~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	
	SPH-8			AB-31, AB-37	30			
	SPH-9			AB-31, AB-37	42		Annut its it	
	SPH-4		AM104	AB-33	2		H mm and	
Small hole stylus*4	SPH-4		AM105	AB-33	4			
	SPH-4	I3 12A	AM106	AB-33	6.5		V	
1 Stylus for SV	1-01500	corioc					Ball dia: 1mm	
C Standard	v-C4300	Series	00				Carbide-tipped	
2 Standard ad							carbiac appea	
3 Standard ad	cessory o	of SV-C320	00 series					
				00 series are n	ot availabl	۵		
T Styli Si I -Z	i, 22, allu	12310130	-0100/41	ou series die li		ι.		

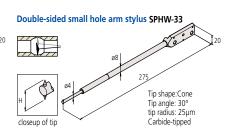
Arm stylus (comprising an arm and stylus)

		,	
Arm stylus name	Stylus No.	Parts No.	H (mm)
	SPHW-31	12AAM108	2.4
Double-sided small hole arm stylus	SPHW-32		5
	SPHW-33	12AAM110	9

*5 Arm Stylus for **SV-C4500 series**



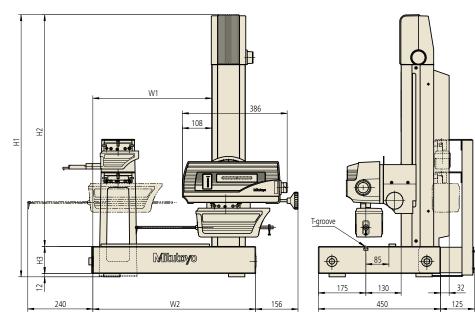






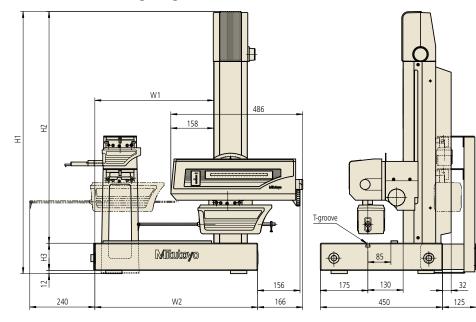
Dimensions

X-axis (drive unit) measuring range : 100mm TYPE (S4/H4/W4)



T-groove size (Common for all models)

X-axis (drive unit) measuring range : 200mm TYPE (S8/H8/W8)



X-axis (drive unit)	Мо	Models		H2	H3	W1	W2
Measuring range	3200 Series	4500 Series	(mm)	(mm)	(mm)	(mm) 438 438 838 438 438 438	(mm)
	SV-C3200S4	SV-C4500S4	966	854	100	438	600
100mm	SV-C3200H4	SV-C4500H4	1166	1054	100	438	600
	SV-C3200W4	SV-C4500W4	1176	1054	110	838	1000
	SV-C320058	SV-C4500S8	966	854	100	438	600
200mm	SV-C3200H8	SV-C4500H8	1166	1054	100	438	600
	SV-C3200W8	SV-C4500W8	1176	1054	110	838	1000

Specifications

Model No.		SV-C3200S4 (525-491A-1)	SV-C3200H4 (525-492A-1)	SV-C3200W4 (525-493A-1)	SV-C3200S8 (525-496A-1)	SV-C3200H8 (525-497A-1)	SV-C3200W4 (525-498A-1)	
(Order No.	.)	SV-C4500S4 (525-451A-1)	SV-C4500H4 (525-452A-1)	SV-C4500W4 (525-453A-1)	SV-C4500S8 (525-456A-1)	SV-C4500H8 (525-457A-1)	SV-C4500W8 (525-458A-1)	
Specificati	ions for Surface Roughr	ess Measurement						
Measuring	X axis (drive unit)		100mm 200mm					
range	Z1 axis (detector unit)			800µm / 8	0µm / 8µm			
Straightnes	is	(0.05+0.001L) μm L = Drive length (mm) (0.1+0.002L) μm (4+2L) μin						
Resolution	Z1 axis (detector unit)		0.0	1µm (800µm) , 0.001µr	n (80µm) , 0.0001µm (8	μm)		
Measuring	force			0.75mN	l or 4mN			
Stylus tip			60°, 2µmR (Me	asuring force: 0.75mN	or 90°, 5µmR (Measur	ing force: 4mN)		
Conformab	le standards				01/ISO1997/ANSI/VDA			
Parameters	i	R c, Wa, Wq, Wsk, W	ku, Wp, Wv, Wz, Wt, V	Vc, WSm, W∆q, Wm (rC	Rq, Rsk, Rku, Rp, Rv, Rz) Wmr, Wôc, Rk, Rpk, R 5, NR, NCRX, CPM, SR, S	vk, Mr1, Mr2, A1, A2, R	(rC) Rmr, x, AR, R, Wx, AW, W,	
Assessed pr	ofiles		aviness curve, Rolling	circle waviness curve,	curve, Filtered wavine Roughness motif, Wav	viness motif, DIN4776	curve	
Graphs			ation angle distributi	on curve, Peak point h	, Power spectrum curv eight distribution curv	e, Parameter distribut	ion curve	
Data compe	ensation	Tilt compensation, R-surface compensation, Ellipse Compensation, Parabola compensation, Hyperbolic compensation, Polynomial compensation, Conic automatic compensation, Polynomial automatic compensation						
Filters		Gaussian filter, 2CRPC75, 2CRPC50, 2CR75, 2CR50, Robust spline filter						
Specificati	ions for Contour Measu	irement						
Measuring	X axis (drive unit)		100mm			200mm		
range	Z1 axis (detector unit)			60mm (±30mm in l	norizontal situation)			
Straightnes (when the	X axis is horizontal)		0.8µm / 100mm			2µm / 200mm		
	X axis (drive unit)	± (0.8+0	.01L) µm L = Drive len	<u> </u>		.02L) μm L = Drive len	gth (mm)	
Accuracy	Z1 axis (detector unit)		SV-C3200 serie H = M	es: ± (1.6+ 2Η /100) μm easurement height fro	, SV-C4500 series: ± (m the horizontal position	0.8+ 2H /100) µm on (mm)		
	X axis (drive unit)	0.05µm						
Resolution	Z1 axis (detector unit)	SV-C3200 series: 0.04µm, SV-C4500 series: 0.02µm						
	Z2 axis (column)	1µm						
Measuring	force	SV-C3200 series: 30mN, SV-C4500 series:10, 20, 30, 40, 50mN (Setting measuring force FORMTRACEPAK)						
Measuring	face direction	SV-C3200 series: Both upward and downward, SV-C4500 series: Both upward and downward (direction switch from FORMTRACEPAK)						
	Specifications		1		1			
•	umn) travel range	300mm	50)mm	300mm	500)mm	
X-axis inclin	nation angle			±	45°			
Drive	X axis			0~80mm/s and r	nanual operation			
speed	Z2 axis (column)	0~30mm/s and manual operation						
Measuring s	speed			0.02~	5mm/s			



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